# E·XFL

#### Intel - EP20K200EQC208-1 Datasheet



Welcome to E-XFL.COM

#### Understanding <u>Embedded - FPGAs (Field</u> <u>Programmable Gate Array)</u>

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

#### **Applications of Embedded - FPGAs**

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details	
Product Status	Obsolete
Number of LABs/CLBs	832
Number of Logic Elements/Cells	8320
Total RAM Bits	106496
Number of I/O	136
Number of Gates	526000
Voltage - Supply	1.71V ~ 1.89V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	208-BFQFP
Supplier Device Package	208-PQFP (28x28)
Purchase URL	https://www.e-xfl.com/product-detail/intel/ep20k200eqc208-1

Email: info@E-XFL.COM

- - --

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

Feature	APEX 20K Devices	APEX 20KE Devices
MultiCore system integration	Full support	Full support
SignalTap logic analysis	Full support	Full support
32/64-Bit, 33-MHz PCI	Full compliance in -1, -2 speed grades	Full compliance in -1, -2 speed grades
32/64-Bit, 66-MHz PCI	-	Full compliance in -1 speed grade
MultiVolt I/O	2.5-V or 3.3-V $V_{CCIO}$ V <sub>CCIO</sub> selected for device Certain devices are 5.0-V tolerant	1.8-V, 2.5-V, or 3.3-V V <sub>CCIO</sub> V <sub>CCIO</sub> selected block-by-block 5.0-V tolerant with use of external resistor
ClockLock support	Clock delay reduction 2× and 4× clock multiplication	Clock delay reduction $m/(n \times v)$ or $m/(n \times k)$ clock multiplication Drive ClockLock output off-chip External clock feedback ClockShift LVDS support Up to four PLLs ClockShift, clock phase adjustment
Dedicated clock and input pins	Six	Eight
I/O standard support	2.5-V, 3.3-V, 5.0-V I/O 3.3-V PCI Low-voltage complementary metal-oxide semiconductor (LVCMOS) Low-voltage transistor-to-transistor logic (LVTTL)	1.8-V, 2.5-V, 3.3-V, 5.0-V I/O 2.5-V I/O 3.3-V PCI and PCI-X 3.3-V Advanced Graphics Port (AGP) Center tap terminated (CTT) GTL+ LVCMOS LVTTL True-LVDS and LVPECL data pins (in EP20K300E and larger devices) LVDS and LVPECL signaling (in all BGA and FineLine BGA devices) LVDS and LVPECL data pins up to 156 Mbps (in -1 speed grade devices) HSTL Class I PCI-X SSTL-2 Class I and II SSTL-3 Class I and II
Memory support	Dual-port RAM FIFO RAM ROM	CAM Dual-port RAM FIFO RAM ROM

### Functional Description

APEX 20K devices incorporate LUT-based logic, product-term-based logic, and memory into one device. Signal interconnections within APEX 20K devices (as well as to and from device pins) are provided by the FastTrack<sup>®</sup> Interconnect—a series of fast, continuous row and column channels that run the entire length and width of the device.

Each I/O pin is fed by an I/O element (IOE) located at the end of each row and column of the FastTrack Interconnect. Each IOE contains a bidirectional I/O buffer and a register that can be used as either an input or output register to feed input, output, or bidirectional signals. When used with a dedicated clock pin, these registers provide exceptional performance. IOEs provide a variety of features, such as 3.3-V, 64-bit, 66-MHz PCI compliance; JTAG BST support; slew-rate control; and tri-state buffers. APEX 20KE devices offer enhanced I/O support, including support for 1.8-V I/O, 2.5-V I/O, LVCMOS, LVTTL, LVPECL, 3.3-V PCI, PCI-X, LVDS, GTL+, SSTL-2, SSTL-3, HSTL, CTT, and 3.3-V AGP I/O standards.

The ESB can implement a variety of memory functions, including CAM, RAM, dual-port RAM, ROM, and FIFO functions. Embedding the memory directly into the die improves performance and reduces die area compared to distributed-RAM implementations. Moreover, the abundance of cascadable ESBs ensures that the APEX 20K device can implement multiple wide memory blocks for high-density designs. The ESB's high speed ensures it can implement small memory blocks without any speed penalty. The abundance of ESBs ensures that designers can create as many different-sized memory blocks as the system requires. Figure 1 shows an overview of the APEX 20K device.



Each LE has two outputs that drive the local, MegaLAB, or FastTrack Interconnect routing structure. Each output can be driven independently by the LUT's or register's output. For example, the LUT can drive one output while the register drives the other output. This feature, called register packing, improves device utilization because the register and the LUT can be used for unrelated functions. The LE can also drive out registered and unregistered versions of the LUT output.

The APEX 20K architecture provides two types of dedicated high-speed data paths that connect adjacent LEs without using local interconnect paths: carry chains and cascade chains. A carry chain supports high-speed arithmetic functions such as counters and adders, while a cascade chain implements wide-input functions such as equality comparators with minimum delay. Carry and cascade chains connect LEs 1 through 10 in an LAB and all LABs in the same MegaLAB structure.

#### Carry Chain

The carry chain provides a very fast carry-forward function between LEs. The carry-in signal from a lower-order bit drives forward into the higherorder bit via the carry chain, and feeds into both the LUT and the next portion of the carry chain. This feature allows the APEX 20K architecture to implement high-speed counters, adders, and comparators of arbitrary width. Carry chain logic can be created automatically by the Quartus II software Compiler during design processing, or manually by the designer during design entry. Parameterized functions such as library of parameterized modules (LPM) and DesignWare functions automatically take advantage of carry chains for the appropriate functions.

The Quartus II software Compiler creates carry chains longer than ten LEs by linking LABs together automatically. For enhanced fitting, a long carry chain skips alternate LABs in a MegaLAB<sup>™</sup> structure. A carry chain longer than one LAB skips either from an even-numbered LAB to the next even-numbered LAB, or from an odd-numbered LAB to the next odd-numbered LAB. For example, the last LE of the first LAB in the upper-left MegaLAB structure carries to the first LE of the third LAB in the MegaLAB structure.

Figure 6 shows how an *n*-bit full adder can be implemented in n + 1 LEs with the carry chain. One portion of the LUT generates the sum of two bits using the input signals and the carry-in signal; the sum is routed to the output of the LE. The register can be bypassed for simple adders or used for accumulator functions. Another portion of the LUT and the carry chain logic generates the carry-out signal, which is routed directly to the carry-in signal of the next-higher-order bit. The final carry-out signal is routed to an LE, where it is driven onto the local, MegaLAB, or FastTrack Interconnect routing structures.

#### Normal Mode

The normal mode is suitable for general logic applications, combinatorial functions, or wide decoding functions that can take advantage of a cascade chain. In normal mode, four data inputs from the LAB local interconnect and the carry-in are inputs to a four-input LUT. The Quartus II software Compiler automatically selects the carry-in or the DATA3 signal as one of the inputs to the LUT. The LUT output can be combined with the cascade-in signal to form a cascade chain through the cascade-out signal. LEs in normal mode support packed registers.

#### **Arithmetic Mode**

The arithmetic mode is ideal for implementing adders, accumulators, and comparators. An LE in arithmetic mode uses two 3-input LUTs. One LUT computes a three-input function; the other generates a carry output. As shown in Figure 8, the first LUT uses the carry-in signal and two data inputs from the LAB local interconnect to generate a combinatorial or registered output. For example, when implementing an adder, this output is the sum of three signals: DATA1, DATA2, and carry-in. The second LUT uses the same three signals to generate a carry-out signal, thereby creating a carry chain. The arithmetic mode also supports simultaneous use of the cascade chain. LEs in arithmetic mode can drive out registered and unregistered versions of the LUT output.

The Quartus II software implements parameterized functions that use the arithmetic mode automatically where appropriate; the designer does not need to specify how the carry chain will be used.

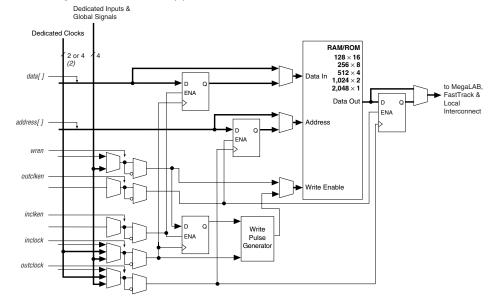
#### **Counter Mode**

The counter mode offers clock enable, counter enable, synchronous up/down control, synchronous clear, and synchronous load options. The counter enable and synchronous up/down control signals are generated from the data inputs of the LAB local interconnect. The synchronous clear and synchronous load options are LAB-wide signals that affect all registers in the LAB. Consequently, if any of the LEs in an LAB use the counter mode, other LEs in that LAB must be used as part of the same counter or be used for a combinatorial function. The Quartus II software automatically places any registers that are not used by the counter into other LABs. Figure 11 shows the intersection of a row and column interconnect, and how these forms of interconnects and LEs drive each other.



Figure 11. Driving the FastTrack Interconnect

APEX 20KE devices include an enhanced interconnect structure for faster routing of input signals with high fan-out. Column I/O pins can drive the FastRow<sup>™</sup> interconnect, which routes signals directly into the local interconnect without having to drive through the MegaLAB interconnect. FastRow lines traverse two MegaLAB structures. Also, these pins can drive the local interconnect directly for fast setup times. On EP20K300E and larger devices, the FastRow interconnect drives the two MegaLABs in the top left corner, the two MegaLABs in the top right corner, the two MegaLABS in the bottom left corner, and the two MegaLABs in the bottom right corner. On EP20K200E and smaller devices, FastRow interconnect drives the two MegaLABs on the top and the two MegaLABs on the bottom of the device. On all devices, the FastRow interconnect drives all local interconnect in the appropriate MegaLABs except the local interconnect on the side of the MegaLAB opposite the ESB. Pins using the FastRow interconnect achieve a faster set-up time, as the signal does not need to use a MegaLAB interconnect line to reach the destination LE. Figure 12 shows the FastRow interconnect.



#### Figure 22. ESB in Single-Port Mode Note (1)

#### Notes to Figure 22:

All registers can be asynchronously cleared by ESB local interconnect signals, global signals, or the chip-wide reset.
APEX 20KE devices have four dedicated clocks.

#### **Content-Addressable Memory**

In APEX 20KE devices, the ESB can implement CAM. CAM can be thought of as the inverse of RAM. When read, RAM outputs the data for a given address. Conversely, CAM outputs an address for a given data word. For example, if the data FA12 is stored in address 14, the CAM outputs 14 when FA12 is driven into it.

CAM is used for high-speed search operations. When searching for data within a RAM block, the search is performed serially. Thus, finding a particular data word can take many cycles. CAM searches all addresses in parallel and outputs the address storing a particular word. When a match is found, a match flag is set high. Figure 23 shows the CAM block diagram.

APEX 20KE devices also support the MultiVolt I/O interface feature. The APEX 20KE VCCINT pins must always be connected to a 1.8-V power supply. With a 1.8-V V<sub>CCINT</sub> level, input pins are 1.8-V, 2.5-V, and 3.3-V tolerant. The VCCIO pins can be connected to either a 1.8-V, 2.5-V, or 3.3-V power supply, depending on the I/O standard requirements. When the VCCIO pins are connected to a 1.8-V power supply, the output levels are compatible with 1.8-V systems. When VCCIO pins are connected to a 2.5-V power supply, the output levels are compatible with 2.5-V systems. When VCCIO pins are connected to a 3.3-V power supply, the output levels are sometime with 2.5-V systems. When VCCIO pins are connected to a 3.3-V power supply, the output high is 3.3 V and compatible with 3.3-V or 5.0-V systems. An APEX 20KE device is 5.0-V tolerant with the addition of a resistor.

#### Table 13 summarizes APEX 20KE MultiVolt I/O support.

Table 13. /	Table 13. APEX 20KE MultiVolt I/O Support Note (1)										
V <sub>CCIO</sub> (V)		Input Siç	jnals (V)			Output S	ignals (V)				
	1.8	2.5	3.3	5.0	1.8	2.5	3.3	5.0			
1.8	<b>&gt;</b>	$\checkmark$	<b>&gt;</b>		$\checkmark$						
2.5	$\checkmark$	$\checkmark$	$\checkmark$			$\checkmark$					
3.3	~	$\checkmark$	>	(2)			<b>√</b> (3)				

#### Notes to Table 13:

 The PCI clamping diode must be disabled to drive an input with voltages higher than V<sub>CCIO</sub>, except for the 5.0-V input case.

(2) An APEX 20KE device can be made 5.0-V tolerant with the addition of an external resistor. You also need a PCI clamp and series resistor.

(3) When V<sub>CCIO</sub> = 3.3 V, an APEX 20KE device can drive a 2.5-V device with 3.3-V tolerant inputs.

## ClockLock & ClockBoost Features

APEX 20K devices support the ClockLock and ClockBoost clock management features, which are implemented with PLLs. The ClockLock circuitry uses a synchronizing PLL that reduces the clock delay and skew within a device. This reduction minimizes clock-to-output and setup times while maintaining zero hold times. The ClockBoost circuitry, which provides a clock multiplier, allows the designer to enhance device area efficiency by sharing resources within the device. The ClockBoost circuitry allows the designer to distribute a low-speed clock and multiply that clock on-device. APEX 20K devices include a high-speed clock tree; unlike ASICs, the user does not have to design and optimize the clock tree. The ClockLock and ClockBoost features work in conjunction with the APEX 20K device's high-speed clock to provide significant improvements in system performance and band-width. Devices with an X-suffix on the ordering code include the ClockLock circuit.

The ClockLock and ClockBoost features in APEX 20K devices are enabled through the Quartus II software. External devices are not required to use these features.

Symbol	Parameter	Min	Max	Unit
t <sub>SKEW</sub>	Skew delay between related ClockLock/ClockBoost-generated clocks		500	ps
JITTER	Jitter on ClockLock/ClockBoost-generated clock (5)		200	ps
t <sub>INCLKSTB</sub>	Input clock stability (measured between adjacent clocks)		50	ps

Notes to Table 15:

- (1) The PLL input frequency range for the EP20K100-1X device for 1x multiplication is 25 MHz to 175 MHz.
- (2) All input clock specifications must be met. The PLL may not lock onto an incoming clock if the clock specifications are not met, creating an erroneous clock within the device.
- (3) During device configuration, the ClockLock and ClockBoost circuitry is configured first. If the incoming clock is supplied during configuration, the ClockLock and ClockBoost circuitry locks during configuration, because the lock time is less than the configuration time.
- (4) The jitter specification is measured under long-term observation.
- (5) If the input clock stability is 100 ps,  $t_{JITTER}$  is 250 ps.

# Table 16 summarizes the APEX 20K ClockLock and ClockBoost parameters for -2 speed grade devices.

Symbol	Parameter	Min	Max	Unit
f <sub>out</sub>	Output frequency	25	170	MHz
f <sub>CLK1</sub>	Input clock frequency (ClockBoost clock multiplication factor equals 1)	25	170	MHz
f <sub>CLK2</sub>	Input clock frequency (ClockBoost clock multiplication factor equals 2)	16	80	MHz
f <sub>CLK4</sub>	Input clock frequency (ClockBoost clock multiplication factor equals 4)	10	34	MHz
t <sub>OUTDUTY</sub>	Duty cycle for ClockLock/ClockBoost-generated clock	40	60	%
f <sub>CLKDEV</sub>	Input deviation from user specification in the Quartus II software (ClockBoost clock multiplication factor equals one) (1)		25,000 (2)	PPM
t <sub>R</sub>	Input rise time		5	ns
t <sub>F</sub>	Input fall time		5	ns
t <sub>LOCK</sub>	Time required for ClockLock/ ClockBoost to acquire lock (3)		10	μs
t <sub>SKEW</sub>	Skew delay between related ClockLock/ ClockBoost- generated clock	500	500	ps
t <sub>JITTER</sub>	Jitter on ClockLock/ ClockBoost-generated clock (4)		200	ps
t <sub>INCLKSTB</sub>	Input clock stability (measured between adjacent clocks)		50	ps

#### Table 16. APEX 20K ClockLock & ClockBoost Parameters for -2 Speed Grade Devices

Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
V <sub>OL</sub>	3.3-V low-level TTL output voltage	I <sub>OL</sub> = 12 mA DC, V <sub>CCIO</sub> = 3.00 V (11)			0.45	V
	3.3-V low-level CMOS output voltage	I <sub>OL</sub> = 0.1 mA DC, V <sub>CCIO</sub> = 3.00 V (11)			0.2	V
	3.3-V low-level PCI output voltage	I <sub>OL</sub> = 1.5 mA DC, V <sub>CCIO</sub> = 3.00 to 3.60 V (11)			$0.1  imes V_{CCIO}$	V
	2.5-V low-level output voltage	I <sub>OL</sub> = 0.1 mA DC, V <sub>CCIO</sub> = 2.30 V (11)			0.2	V
		I <sub>OL</sub> = 1 mA DC, V <sub>CCIO</sub> = 2.30 V (11)			0.4	V
		I <sub>OL</sub> = 2 mA DC, V <sub>CCIO</sub> = 2.30 V (11)			0.7	V
l <sub>l</sub>	Input pin leakage current	$V_1 = 5.75$ to $-0.5$ V	-10		10	μA
I <sub>OZ</sub>	Tri-stated I/O pin leakage current	V <sub>O</sub> = 5.75 to -0.5 V	-10		10	μΑ
I <sub>CC0</sub>	V <sub>CC</sub> supply current (standby) (All ESBs in power-down mode)	$V_1$ = ground, no load, no toggling inputs, -1 speed grade (12)		10		mA
		V <sub>I</sub> = ground, no load, no toggling inputs, -2, -3 speed grades (12)		5		mA
R <sub>CONF</sub>	Value of I/O pin pull-up resistor	V <sub>CCIO</sub> = 3.0 V (13)	20		50	W
	before and during configuration	V <sub>CCIO</sub> = 2.375 V (13)	30		80	W

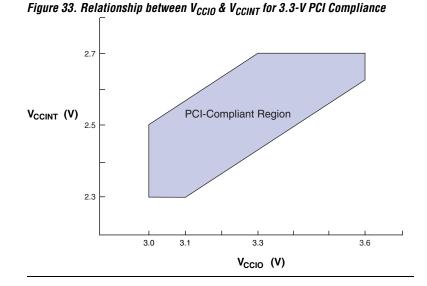
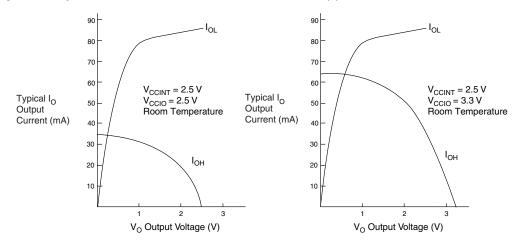
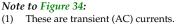


Figure 34 shows the typical output drive characteristics of APEX 20K devices with 3.3-V and 2.5-V V<sub>CCIO</sub>. The output driver is compatible with the 3.3-V *PCI Local Bus Specification, Revision 2.2* (when VCCIO pins are connected to 3.3 V). 5-V tolerant APEX 20K devices in the -1 speed grade are 5-V PCI compliant over all operating conditions.

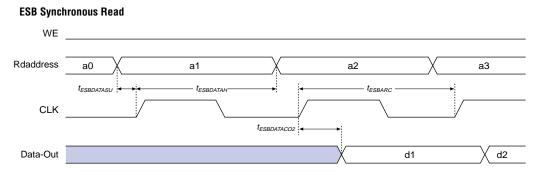






**Altera Corporation** 

Figure 39. ESB Synchronous Timing Waveforms



#### ESB Synchronous Write (ESB Output Registers Used)

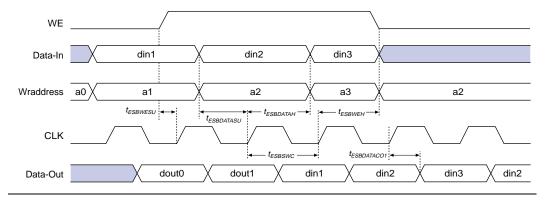


Figure 40 shows the timing model for bidirectional I/O pin timing.

Symbol	-1 Spee	d Grade	-2 Spee	d Grade	-3 Spee	Units	
	Min	Мах	Min	Max	Min	Max	
t <sub>SU</sub>	0.5		0.6		0.8		ns
t <sub>H</sub>	0.7		0.8		1.0		ns
t <sub>co</sub>		0.3		0.4		0.5	ns
t <sub>lut</sub>		0.8		1.0		1.3	ns
t <sub>ESBRC</sub>		1.7		2.1		2.4	ns
t <sub>ESBWC</sub>		5.7		6.9		8.1	ns
t <sub>ESBWESU</sub>	3.3		3.9		4.6		ns
t <sub>ESBDATASU</sub>	2.2		2.7		3.1		ns
t <sub>ESBDATAH</sub>	0.6		0.8		0.9		ns
t <sub>ESBADDRSU</sub>	2.4		2.9		3.3		ns
t <sub>ESBDATACO1</sub>		1.3		1.6		1.8	ns
t <sub>ESBDATACO2</sub>		2.6		3.1		3.6	ns
t <sub>ESBDD</sub>		2.5		3.3		3.6	ns
t <sub>PD</sub>		2.5		3.0		3.6	ns
t <sub>PTERMSU</sub>	2.3		2.7		3.2		ns
t <sub>PTERMCO</sub>		1.5		1.8		2.1	ns
t <sub>F1-4</sub>		0.5		0.6		0.7	ns
t <sub>F5-20</sub>		1.6		1.7		1.8	ns
t <sub>F20+</sub>		2.2		2.2		2.3	ns
t <sub>CH</sub>	2.0		2.5		3.0		ns
t <sub>CL</sub>	2.0		2.5		3.0		ns
t <sub>CLRP</sub>	0.3		0.4		0.4		ns
t <sub>PREP</sub>	0.4		0.5		0.5		ns
t <sub>ESBCH</sub>	2.0		2.5		3.0		ns
t <sub>ESBCL</sub>	2.0		2.5		3.0		ns
t <sub>ESBWP</sub>	1.6		1.9		2.2		ns
t <sub>ESBRP</sub>	1.0		1.3		1.4		ns

Symbol	-1 Spee	d Grade	-2 Speed Grade		-3 Speed Grade		Units	
					-		_	
	Min	Max	Min	Max	Min	Max		
t <sub>SU</sub>	0.1		0.3		0.6		ns	
t <sub>H</sub>	0.5		0.8		0.9		ns	
t <sub>CO</sub>		0.1		0.4		0.6	ns	
t <sub>LUT</sub>		1.0		1.2		1.4	ns	
t <sub>ESBRC</sub>		1.7		2.1		2.4	ns	
t <sub>ESBWC</sub>		5.7		6.9		8.1	ns	
t <sub>ESBWESU</sub>	3.3		3.9		4.6		ns	
t <sub>ESBDATASU</sub>	2.2		2.7		3.1		ns	
t <sub>ESBDATAH</sub>	0.6		0.8		0.9		ns	
t <sub>ESBADDRSU</sub>	2.4		2.9		3.3		ns	
t <sub>ESBDATACO1</sub>		1.3		1.6		1.8	ns	
t <sub>ESBDATACO2</sub>		2.5		3.1		3.6	ns	
t <sub>ESBDD</sub>		2.5		3.3		3.6	ns	
t <sub>PD</sub>		2.5		3.1		3.6	ns	
t <sub>PTERMSU</sub>	1.7		2.1		2.4		ns	
t <sub>PTERMCO</sub>		1.0		1.2		1.4	ns	
t <sub>F1-4</sub>		0.4		0.5		0.6	ns	
t <sub>F5-20</sub>		2.6		2.8		2.9	ns	
t <sub>F20+</sub>		3.7		3.8		3.9	ns	
t <sub>CH</sub>	2.0		2.5		3.0		ns	
t <sub>CL</sub>	2.0		2.5		3.0		ns	
t <sub>CLRP</sub>	0.5		0.6		0.8		ns	
t <sub>PREP</sub>	0.5		0.5		0.5		ns	
t <sub>ESBCH</sub>	2.0		2.5		3.0		ns	
t <sub>ESBCL</sub>	2.0		2.5		3.0		ns	
t <sub>ESBWP</sub>	1.5		1.9		2.2		ns	
t <sub>ESBRP</sub>	1.0		1.2		1.4		ns	

Tables 43 through 48 show the I/O external and external bidirectional timing parameter values for EP20K100, EP20K200, and EP20K400 APEX 20K devices.

Tables 55 through 60 describe  $f_{MAX}$  LE Timing Microparameters,  $f_{MAX}$  ESB Timing Microparameters,  $f_{MAX}$  Routing Delays, Minimum Pulse Width Timing Parameters, External Timing Parameters, and External Bidirectional Timing Parameters for EP20K60E APEX 20KE devices.

Table 55. EP2	OK60E f <sub>max</sub> L	E Timing Micr	oparameters				
Symbol	nbol -1 -2		-	Unit			
	Min	Max	Min	Max	Min	Max	
t <sub>SU</sub>	0.17		0.15		0.16		ns
t <sub>H</sub>	0.32		0.33		0.39		ns
t <sub>CO</sub>		0.29		0.40		0.60	ns
t <sub>LUT</sub>		0.77		1.07		1.59	ns

Symbol	-'	1	-	2	-:	Unit	
	Min	Max	Min	Max	Min	Max	
t <sub>ESBARC</sub>		1.61		1.84		1.97	ns
t <sub>ESBSRC</sub>		2.57		2.97		3.20	ns
t <sub>ESBAWC</sub>		0.52		4.09		4.39	ns
t <sub>ESBSWC</sub>		3.17		3.78		4.09	ns
t <sub>ESBWASU</sub>	0.56		6.41		0.63		ns
t <sub>ESBWAH</sub>	0.48		0.54		0.55		ns
t <sub>ESBWDSU</sub>	0.71		0.80		0.81		ns
t <sub>ESBWDH</sub>	.048		0.54		0.55		ns
t <sub>ESBRASU</sub>	1.57		1.75		1.87		ns
t <sub>ESBRAH</sub>	0.00		0.00		0.20		ns
t <sub>ESBWESU</sub>	1.54		1.72		1.80		ns
t <sub>ESBWEH</sub>	0.00		0.00		0.00		ns
t <sub>ESBDATASU</sub>	-0.16		-0.20		-0.20		ns
t <sub>ESBDATAH</sub>	0.13		0.13		0.13		ns
t <sub>ESBWADDRSU</sub>	0.12		0.08		0.13		ns
t <sub>ESBRADDRSU</sub>	0.17		0.15		0.19		ns
t <sub>ESBDATACO1</sub>		1.20		1.39		1.52	ns
t <sub>ESBDATACO2</sub>		2.54		2.99		3.22	ns
t <sub>ESBDD</sub>		3.06		3.56		3.85	ns
t <sub>PD</sub>		1.73		2.02		2.20	ns
t <sub>PTERMSU</sub>	1.11		1.26		1.38		ns
t <sub>PTERMCO</sub>		1.19		1.40		1.08	ns

Table 63. EP2	OK100E f <sub>max</sub> i	Routing Delay	S				
Symbol	-1 -2		-2	-;	Unit		
	Min	Max	Min	Max	Min	Мах	
t <sub>F1-4</sub>		0.24		0.27		0.29	ns
t <sub>F5-20</sub>		1.04		1.26		1.52	ns
t <sub>F20+</sub>		1.12		1.36		1.86	ns

Symbol	-1 Spee	d Grade	-2 Spee	ed Grade	-3 Spee	Unit	
	Min	Max	Min	Max	Min	Max	
t <sub>ESBARC</sub>		1.78		2.02		1.95	ns
t <sub>ESBSRC</sub>		2.52		2.91		3.14	ns
t <sub>ESBAWC</sub>		3.52		4.11		4.40	ns
t <sub>ESBSWC</sub>		3.23		3.84		4.16	ns
t <sub>ESBWASU</sub>	0.62		0.67		0.61		ns
t <sub>ESBWAH</sub>	0.41		0.55		0.55		ns
t <sub>ESBWDSU</sub>	0.77		0.79		0.81		ns
t <sub>ESBWDH</sub>	0.41		0.55		0.55		ns
t <sub>ESBRASU</sub>	1.74		1.92		1.85		ns
t <sub>ESBRAH</sub>	0.00		0.01		0.23		ns
t <sub>ESBWESU</sub>	2.07		2.28		2.41		ns
t <sub>ESBWEH</sub>	0.00		0.00		0.00		ns
t <sub>ESBDATASU</sub>	0.25		0.27		0.29		ns
t <sub>ESBDATAH</sub>	0.13		0.13		0.13		ns
t <sub>ESBWADDRSU</sub>	0.11		0.04		0.11		ns
t <sub>ESBRADDRSU</sub>	0.14		0.11		0.16		ns
t <sub>ESBDATACO1</sub>		1.29		1.50		1.63	ns
t <sub>ESBDATACO2</sub>		2.55		2.99		3.22	ns
t <sub>ESBDD</sub>		3.12		3.57		3.85	ns
t <sub>PD</sub>		1.84		2.13		2.32	ns
t <sub>PTERMSU</sub>	1.08		1.19		1.32		ns
t <sub>PTERMCO</sub>		1.31		1.53		1.66	ns

Г

٦

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Spee	d Grade	Unit
	Min	Max	Min	Max	Min	Мах	
t <sub>ESBARC</sub>		1.78		2.02		1.95	ns
t <sub>ESBSRC</sub>		2.52		2.91		3.14	ns
t <sub>ESBAWC</sub>		3.52		4.11		4.40	ns
t <sub>ESBSWC</sub>		3.23		3.84		4.16	ns
t <sub>ESBWASU</sub>	0.62		0.67		0.61		ns
t <sub>ESBWAH</sub>	0.41		0.55		0.55		ns
t <sub>ESBWDSU</sub>	0.77		0.79		0.81		ns
t <sub>ESBWDH</sub>	0.41		0.55		0.55		ns
t <sub>ESBRASU</sub>	1.74		1.92		1.85		ns
t <sub>ESBRAH</sub>	0.00		0.01		0.23		ns
t <sub>ESBWESU</sub>	2.07		2.28		2.41		ns
t <sub>ESBWEH</sub>	0.00		0.00		0.00		ns
t <sub>ESBDATASU</sub>	0.25		0.27		0.29		ns
t <sub>ESBDATAH</sub>	0.13		0.13		0.13		ns
t <sub>ESBWADDRSU</sub>	0.11		0.04		0.11		ns
t <sub>ESBRADDRSU</sub>	0.14		0.11		0.16		ns
t <sub>ESBDATACO1</sub>		1.29		1.50		1.63	ns
t <sub>ESBDATACO2</sub>		2.55		2.99		3.22	ns
t <sub>ESBDD</sub>		3.12		3.57		3.85	ns
t <sub>PD</sub>		1.84		2.13		2.32	ns
t <sub>PTERMSU</sub>	1.08		1.19		1.32		ns
t <sub>PTERMCO</sub>		1.31		1.53		1.66	ns

Table 105. EP20K1500E f <sub>MAX</sub> Routing Delays										
Symbol	-1 Speed Grade		-2 Spec	ed Grade	-3 Spee	Unit				
	Min	Max	Min	Мах	Min	Max				
t <sub>F1-4</sub>		0.28		0.28		0.28	ns			
t <sub>F5-20</sub>		1.36		1.50		1.62	ns			
t <sub>F20+</sub>		4.43		4.48		5.07	ns			

Table 108. EP20K1500E External Bidirectional Timing Parameters								
Symbol	-1 Speed Grade		-2 Spee	d Grade	-3 Spee	Unit		
	Min	Max	Min	Max	Min	Max	1	
t <sub>insubidir</sub>	3.47		3.68		3.99		ns	
t <sub>inhbidir</sub>	0.00		0.00		0.00		ns	
t <sub>outcobidir</sub>	2.00	6.18	2.00	6.81	2.00	7.36	ns	
t <sub>XZBIDIR</sub>		6.91		7.62		8.38	ns	
t <sub>zxbidir</sub>		6.91		7.62		8.38	ns	
t <sub>insubidirpll</sub>	3.05		3.26				ns	
t <sub>inhbidirpll</sub>	0.00		0.00				ns	
t <sub>outcobidirpll</sub>	0.50	2.67	0.50	2.99			ns	
t <sub>xzbidirpll</sub>		3.41		3.80			ns	
t <sub>ZXBIDIRPLL</sub>		3.41		3.80			ns	

Tables 109 and 110 show selectable I/O standard input and output delays for APEX 20KE devices. If you select an I/O standard input or output delay other than LVCMOS, add or subtract the selected speed grade to or from the LVCMOS value.

Table 109. Selectable I/O Standard Input Delays								
Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit	
	Min	Max	Min	Max	Min	Max	Min	
LVCMOS		0.00		0.00		0.00	ns	
LVTTL		0.00		0.00		0.00	ns	
2.5 V		0.00		0.04		0.05	ns	
1.8 V		-0.11		0.03		0.04	ns	
PCI		0.01		0.09		0.10	ns	
GTL+		-0.24		-0.23		-0.19	ns	
SSTL-3 Class I		-0.32		-0.21		-0.47	ns	
SSTL-3 Class II		-0.08		0.03		-0.23	ns	
SSTL-2 Class I		-0.17		-0.06		-0.32	ns	
SSTL-2 Class II		-0.16		-0.05		-0.31	ns	
LVDS		-0.12		-0.12		-0.12	ns	
CTT		0.00		0.00		0.00	ns	
AGP		0.00		0.00		0.00	ns	

Г

Table 110. Selectable I/O Standard Output Delays								
Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit	
	Min	Max	Min	Max	Min	Max	Min	
LVCMOS		0.00		0.00		0.00	ns	
LVTTL		0.00		0.00		0.00	ns	
2.5 V		0.00		0.09		0.10	ns	
1.8 V		2.49		2.98		3.03	ns	
PCI		-0.03		0.17		0.16	ns	
GTL+		0.75		0.75		0.76	ns	
SSTL-3 Class I		1.39		1.51		1.50	ns	
SSTL-3 Class II		1.11		1.23		1.23	ns	
SSTL-2 Class I		1.35		1.48		1.47	ns	
SSTL-2 Class II		1.00		1.12		1.12	ns	
LVDS		-0.48		-0.48		-0.48	ns	
CTT		0.00		0.00		0.00	ns	
AGP		0.00		0.00		0.00	ns	

# Power Consumption

To estimate device power consumption, use the interactive power calculator on the Altera web site at **http://www.altera.com**.

# Configuration & Operation

The APEX 20K architecture supports several configuration schemes. This section summarizes the device operating modes and available device configuration schemes.

### **Operating Modes**

The APEX architecture uses SRAM configuration elements that require configuration data to be loaded each time the circuit powers up. The process of physically loading the SRAM data into the device is called configuration. During initialization, which occurs immediately after configuration, the device resets registers, enables I/O pins, and begins to operate as a logic device. The I/O pins are tri-stated during power-up, and before and during configuration. Together, the configuration and initialization processes are called *command mode*; normal device operation is called *user mode*.

Before and during device configuration, all I/O pins are pulled to  $\rm V_{\rm CCIO}$  by a built-in weak pull-up resistor.



101 Innovation Drive San Jose, CA 95134 (408) 544-7000 http://www.altera.com Applications Hotline: (800) 800-EPLD Customer Marketing: (408) 544-7104 Literature Services: lit\_req@altera.com Copyright © 2004 Altera Corporation. All rights reserved. Altera, The Programmable Solutions Company, the stylized Altera logo, specific device designations, and all other words and logos that are identified as trademarks and/or service marks are, unless noted otherwise, the trademarks and service marks of Altera Corporation in the U.S. and other countries. All other product or service names are the property of their respective holders. Altera products are protected under numerous U.S. and foreign patents and pending applications, mask work rights, and copyrights. Altera warrants performance of its semiconductor products to current specifications in accordance with Altera's standard warranty, but reserves the right to make changes

to any products and services at any time without notice. Altera assumes no responsibility or liability arising out of the application or use of any information, product, or service described herein except as expressly agreed to in writing by Altera Corporation. Altera customers are advised to obtain the latest version of device specifications before relying on any published information and before placing orders for products or services.



Altera Corporation